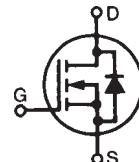


# PolarHT™ HiPerFET Power MOSFET

## IXFC52N30P

$V_{DSS}$  = 300 V  
 $I_{D25}$  = 32 A  
 $R_{DS(on)}$  = 75 mΩ

N-Channel Enhancement Mode



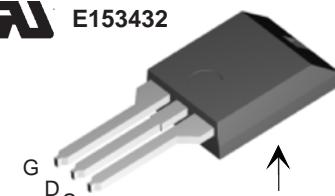
Symbol	Test Conditions	Maximum Ratings		
$V_{DSS}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$	300	V	
$V_{DGR}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$ ; $R_{GS} = 1 \text{ M}\Omega$	300	V	
$V_{GSS}$	Continuous	$\pm 20$	V	
$V_{GSM}$	Transient	$\pm 30$	V	
$I_{D25}$	$T_c = 25^\circ\text{C}$	32	A	
$I_{DM}$	$T_c = 25^\circ\text{C}$ , pulse width limited by $T_{JM}$	150	A	
$I_{AR}$	$T_c = 25^\circ\text{C}$	52	A	
$E_{AR}$	$T_c = 25^\circ\text{C}$	30	mJ	
$E_{AS}$	$T_c = 25^\circ\text{C}$	1.0	J	
$dv/dt$	$I_s \leq I_{DM}$ , $di/dt \leq 100 \text{ A}/\mu\text{s}$ , $V_{DD} \leq V_{DSS}$ , $T_J \leq 150^\circ\text{C}$ , $R_G = 4 \Omega$	10	V/ns	
$P_D$	$T_c = 25^\circ\text{C}$	100	W	
$T_J$		-55 ... +150	°C	
$T_{JM}$		150	°C	
$T_{stg}$		-55 ... +150	°C	
$T_L$	1.6 mm (0.062 in.) from case for 10 s	300	°C	
$V_{ISOL}$	50/60 Hz, RMS, $t = 1\text{ minute}$ , leads-to-tab	2500	V	
$F_c$	Mounting Force	11..65/2.5..15	N/lb	

Weight	ISOPLUS220	2.0	g	
Symbol	Test Conditions	Characteristic Values		
	( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	Min.	Typ.	Max.
$V_{DSS}$	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	300		V
$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 4 \text{ mA}$	2.5		V
$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}_{DC}$ , $V_{DS} = 0$			$\pm 100 \text{ nA}$
$I_{DSS}$	$V_{DS} = V_{DSS}$ $V_{GS} = 0 \text{ V}$			$25 \mu\text{A}$ $250 \mu\text{A}$
$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$ , $I_D = 0.5 I_{D25}$ Pulse test, $t \leq 300 \mu\text{s}$ , duty cycle $d \leq 2\%$	65	75	mΩ

### ISOPLUS220™(IXFC)



E153432



G = Gate  
S = Source

D = Drain  
TAB = Drain

### Features

- Silicon chip on Direct-Copper-Bond substrate
  - High power dissipation
  - Isolated mounting surface
  - 2500V electrical isolation
- Low drain to tab capacitance(<30pF)

### Advantages

- Easy to mount
- Space savings
- High power density

Symbol	Test Conditions	Characteristic Values			
		(T <sub>J</sub> = 25°C, unless otherwise specified)	Min.	Typ.	Max.
<b>g<sub>fs</sub></b>	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 0.5 I <sub>D25</sub> , pulse test	20	30	S	
<b>C<sub>iss</sub></b> <b>C<sub>oss</sub></b> <b>C<sub>rss</sub></b>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1 MHz	3490		pF	
		550		pF	
		130		pF	
<b>t<sub>d(on)</sub></b> <b>t<sub>r</sub></b> <b>t<sub>d(off)</sub></b> <b>t<sub>f</sub></b>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 0.5 V <sub>DSS</sub> , I <sub>D</sub> = I <sub>D25</sub> R <sub>G</sub> = 4 Ω (External)	24		ns	
		22		ns	
		60		ns	
		20		ns	
<b>Q<sub>g(on)</sub></b> <b>Q<sub>gs</sub></b> <b>Q<sub>gd</sub></b>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 0.5 V <sub>DSS</sub> , I <sub>D</sub> = 0.5 I <sub>D25</sub>	110		nC	
		25		nC	
		53		nC	
<b>R<sub>thJC</sub></b>			1.25	K/W	
<b>R<sub>thCK</sub></b>			0.21	K/W	

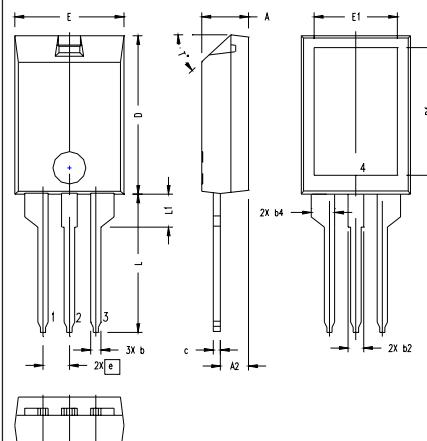
## Source-Drain Diode

## Characteristic Values

(T<sub>J</sub> = 25°C, unless otherwise specified)

Symbol	Test Conditions	min.	typ.	max.
<b>I<sub>s</sub></b>	V <sub>GS</sub> = 0 V		32	A
<b>I<sub>SM</sub></b>	Repetitive		150	A
<b>V<sub>SD</sub></b>	I <sub>F</sub> = I <sub>s</sub> , V <sub>GS</sub> = 0 V, Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %		1.5	V
<b>T<sub>rr</sub></b> <b>Q<sub>RM</sub></b>	I <sub>F</sub> = 25A -di/dt = 100 A/μs V <sub>R</sub> = 100V	250		ns
		1.0		μC

## ISOPLUS220 Outline

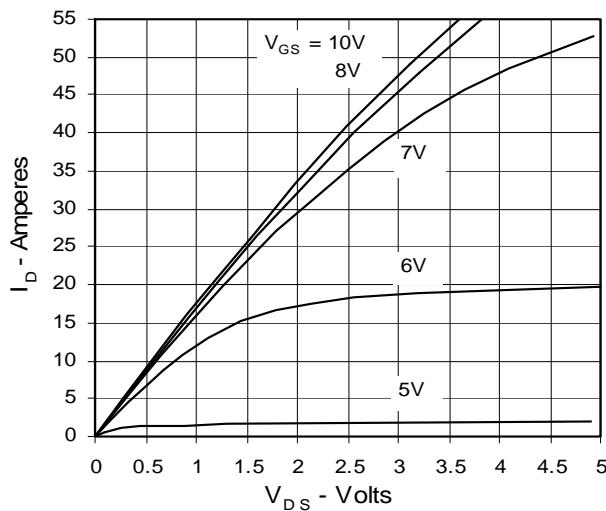


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.157	.197	4.00	5.00
A2	.098	.118	2.50	3.00
b	.035	.051	0.90	1.30
b2	.049	.065	1.25	1.65
b4	.093	.100	2.35	2.55
c	.028	.039	0.70	1.00
D	.591	.630	15.00	16.00
D1	.472	.512	12.00	13.00
E	.394	.433	10.00	11.00
E1	.295	.335	7.50	8.50
e	.100 BASIC		2.55 BASIC	
L	.512	.571	13.00	14.50
L1	.118	.138	3.00	3.50
T*			42.5°	47.5°

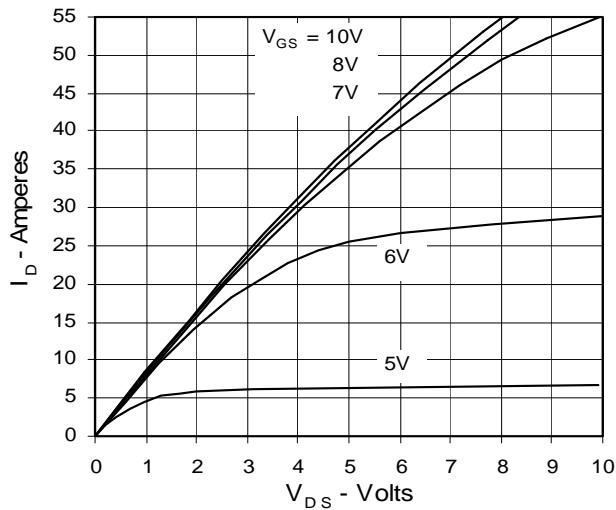
## NOTE:

1. Bottom heatsink (Pin 4) is electrically isolated from Pin 1, 2, or 3.
2. This drawing will meet dimensional requirement of JEDEC SS Product Outline TO-273 except D and D1 dimension.

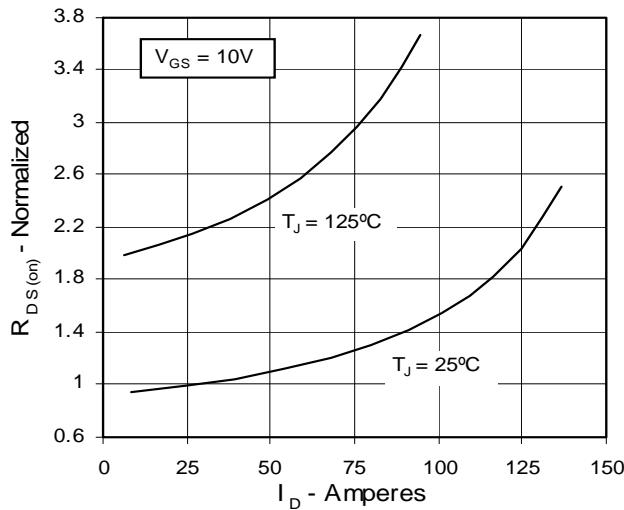
**Fig. 1. Output Characteristics  
@ 25 Deg. C**



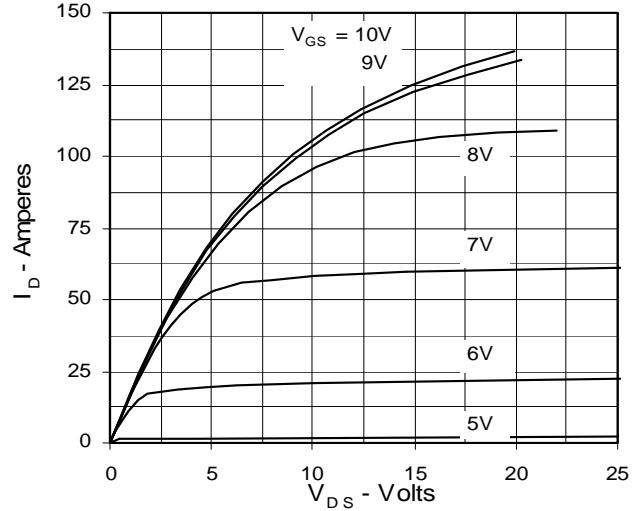
**Fig. 3. Output Characteristics  
@ 125 Deg. C**



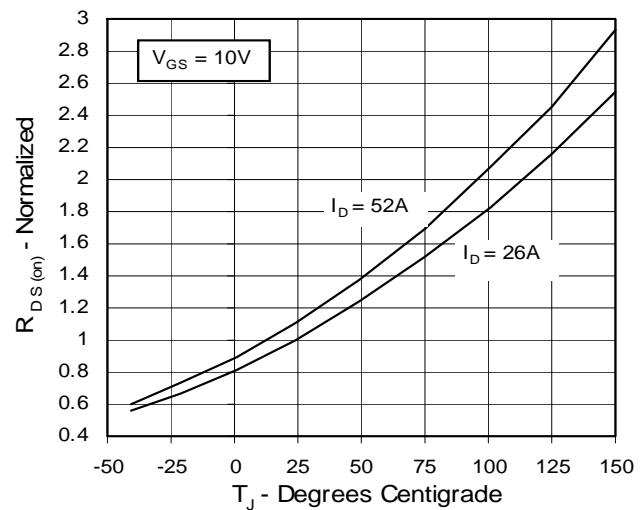
**Fig. 5.  $R_{DS(on)}$  Normalized to  $I_{D25}$  Value vs.  $I_D$**



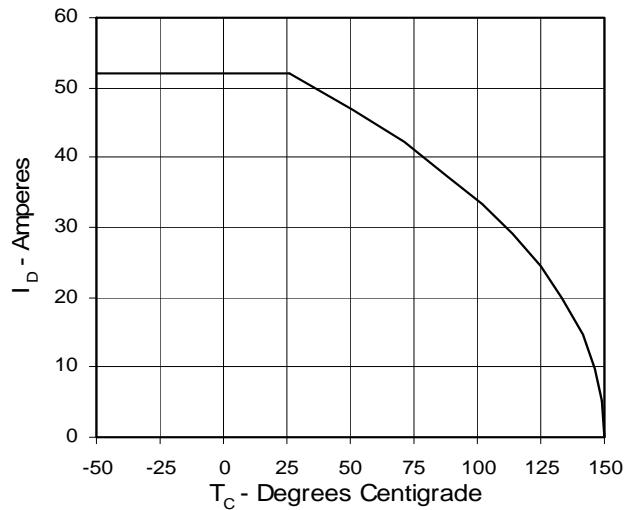
**Fig. 2. Extended Output Characteristics  
@ 25 deg. C**

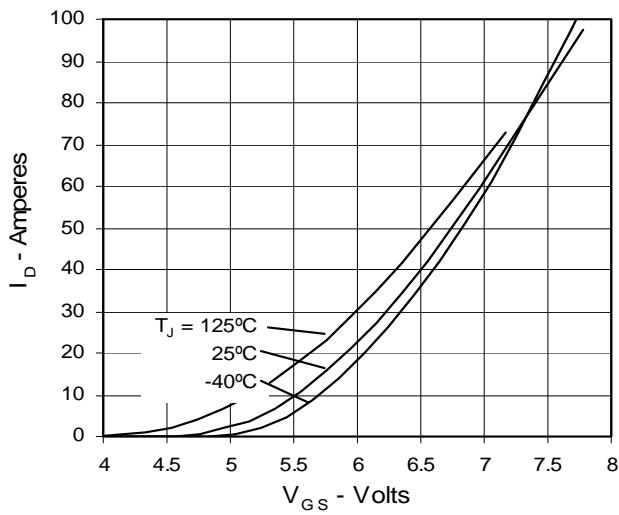
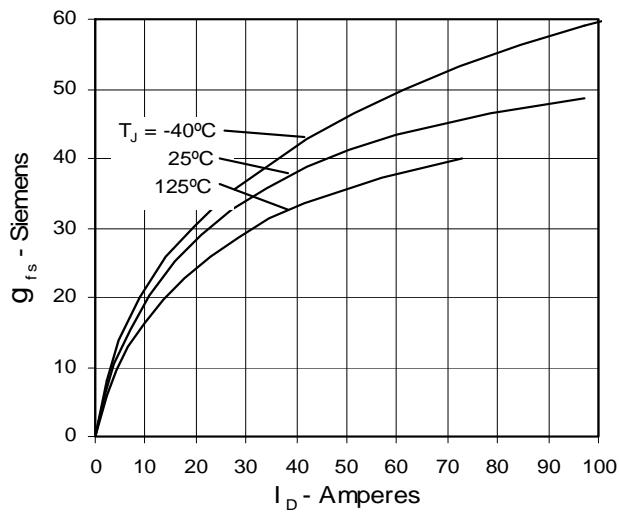
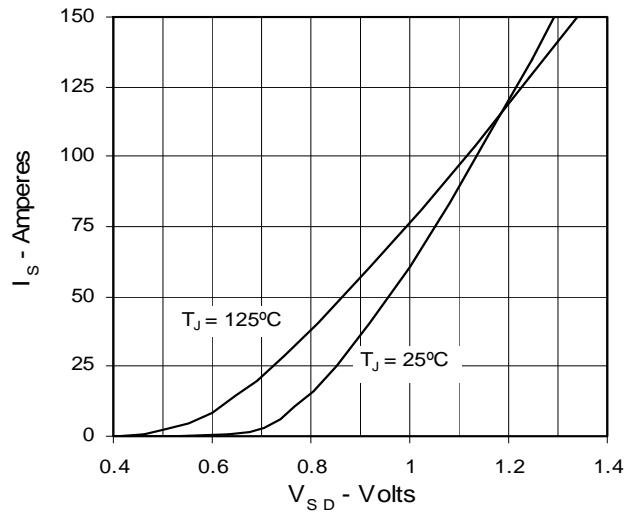
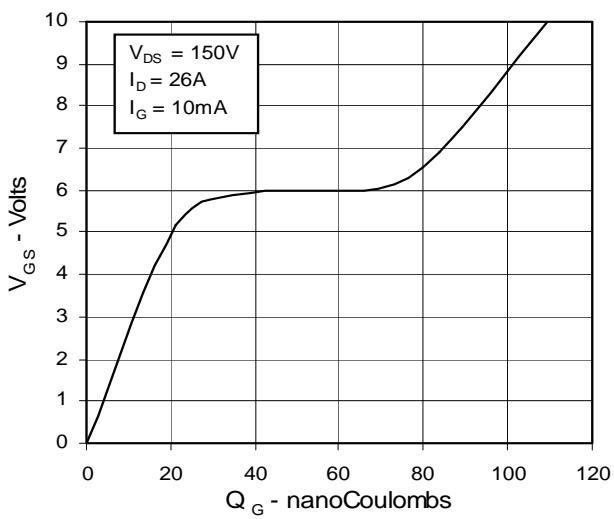
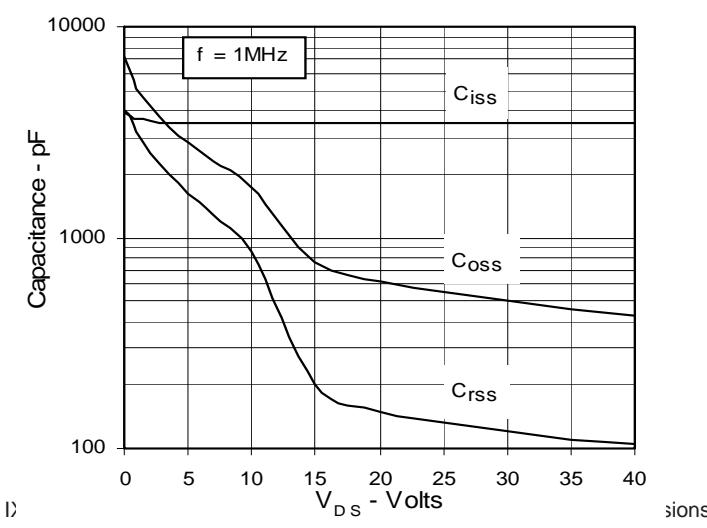
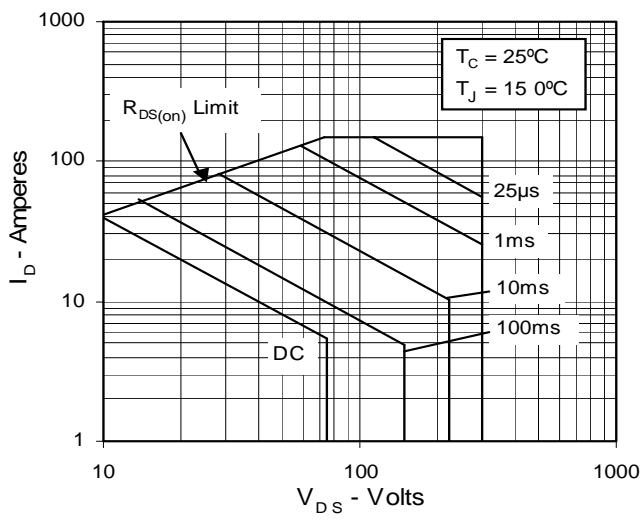


**Fig. 4.  $R_{DS(on)}$  Normalized to  $I_{D25}$  Value vs.  
Junction Temperature**

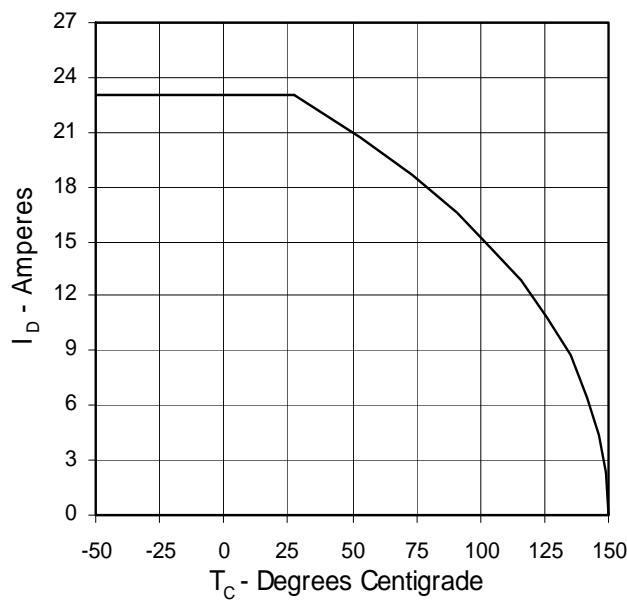


**Fig. 6. Drain Current vs. Case  
Temperature**

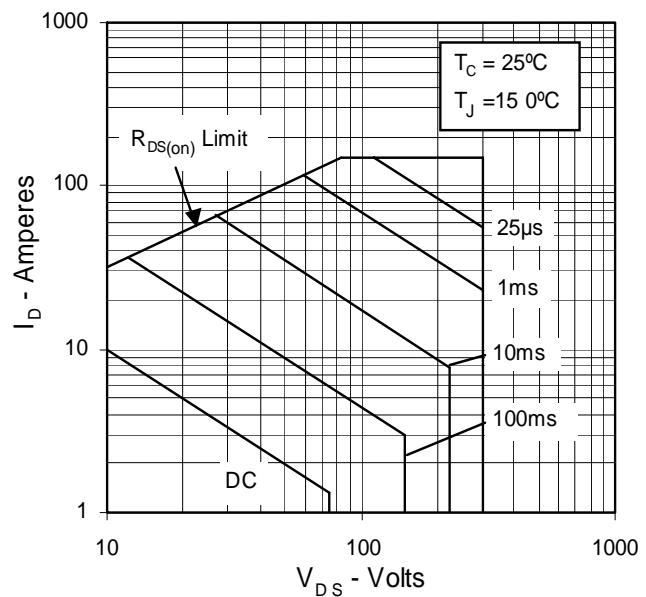


**Fig. 7. Input Admittance****Fig. 8. Transconductance****Fig. 9. Source Current vs. Source-To-Drain Voltage****Fig. 10. Gate Charge****Fig. 11. Capacitance****Fig. 12. Forward-Bias Safe Operating Area**

**Fig. 6. Drain Current vs. Case Temperature**



**Fig. 12. Forward-Bias Safe Operating Area**



**Fig. 13. Maximum Transient Thermal Resistance**

